Model: XB-200

Analytical Probe Station

>> The Probe Station XB-200

is a dedicated probing solution that comes with everything you need to achieve accurate measurement results in the shortest time, with maximum confidence. The system Provides best known methods for I-V/C-V measurements.

Designed for upgradability and extendable with multiple options. The Probe Station XB-200 can be easily reconfigured to meet your future project requirements, such as high voltage testing.

>> Accessories

Microscope Magnification: 1000X Hot Chuck: 200/300/400°C Special Chuck Design for RF CCD and Screen Micropositioner Tip Holder Shielding Box

Vibration Free Table

Platen Up/Down 6mm Adjustable/Coarse Adjustment/Lever-Driven Platen Up/Down 25mm Adjustable/Fine Adjustment/Hand wheel-Driven

>> Specifications

Vacuum Chuck 8" Huged-Knob Chuck Stage Chuck stage 8"×8" Travel Chuck Theta 0°~30° Chuck Up/Down 4mm Adjustable Microscope Stage 2"×2" Travel 660mmW x 660mmD x 700mmH With Microscope Weight 80kg with microscope

